

DESCRIPTION

The 82S226 and 82S229 include on-chip decoding and 2 chip enable inputs for ease of memory expansion. They feature either open collector or tri-state outputs for optimization of word expansion in bused organizations.

Both 82S226 and 82S229 devices are available in the commercial and military temperature ranges. For the commercial temperature range (0°C to +75°C) specify N82S226/229, F or N, and for the military temperature range (-55°C to +125°C specify S82S226/229, F only.

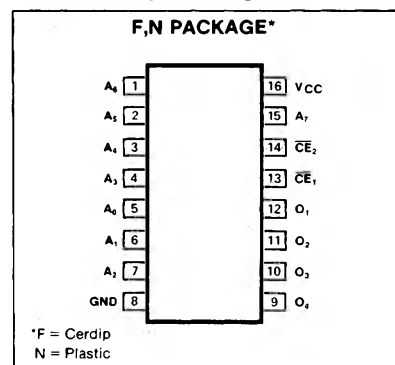
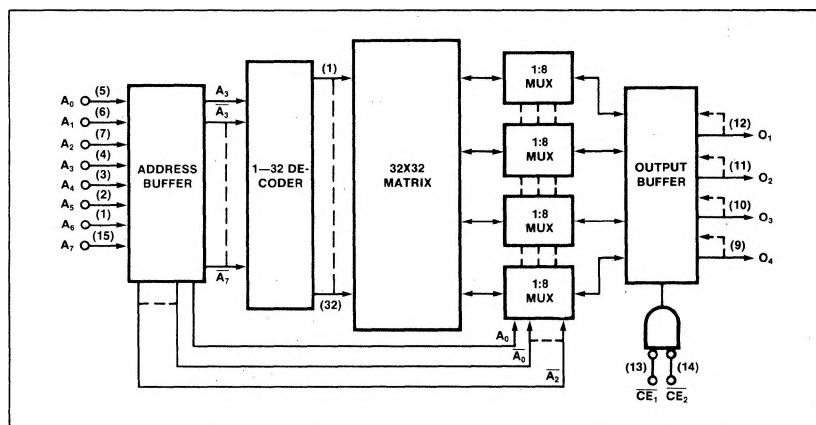
FEATURES

- Address access time:
N82S226/229: 50ns max
S82S226/229 70ns max

- Power dissipation: 0.5mW/bit typ
- Input loading:
N82S226/229: -100 μ A max
S82S226/229: -150 μ A max
- On-chip address decoding
- Output options:
82S226: Open collector
82S229: Tri-state
- Fully compatible with Signetics 82S126/129 1024-bit PROMs
- Fully TTL compatible

APPLICATIONS

- Volume production
- Sequential controllers
- Microprogramming
- Hardwired algorithms
- Control store
- Random logic
- Code conversion

PIN CONFIGURATION**BLOCK DIAGRAM****ABSOLUTE MAXIMUM RATINGS**

PARAMETER	RATING	UNIT
V _{CC} Supply voltage	+7	Vdc
V _{IN} Input voltage	+5.5	Vdc
Output voltage		Vdc
V _{OH} High (82S226)	+5.5	
V _O Off-state (82S229)	+5.5	
Temperature range		°C
T _A Operating	0 to +75	
N82S226/229	-55 to +125	
S82S226/229	-65 to +150	
T _{STG} Storage		

DC ELECTRICAL CHARACTERISTICS N82S226/229: $0^{\circ}\text{C} \leq T_A \leq +75^{\circ}\text{C}$, $4.75\text{V} \leq V_{CC} \leq 5.25\text{V}$
 S82S226/229: $-55^{\circ}\text{C} \leq T_A \leq +125^{\circ}\text{C}$, $4.5\text{V} \leq V_{CC} \leq 5.5\text{V}$

PARAMETER	TEST CONDITIONS ¹	N82S226/229			S82S226/229			UNIT
		Min	Typ ²	Max	Min	Typ ²	Max	
V_{IL} V_{IH} V_{IC}	Input voltage Low High Clamp							V
		2.0	-0.8	-1.2	2.0	-0.8	-1.2	
V_{OL} V_{OH}	Output voltage Low High (82S229)			0.45			0.5	V
		2.4			2.4			
I_{IL} I_{IH}	Input current Low High			-100 40			-150 50	μA
I_{OLK} $I_{O(OFF)}$	Output current Leakage (82S226) Hi-Z state (82S229)			40 40			60 60	μA
I_{OS}	Short circuit (82S229)			-40 -70			-60 -85	μA
I_{CC}	V_{CC} supply current			-20			-15	mA
			105	120		105	125	
C_{IN} C_{OUT}	Capacitance Input Output							pF
			5 8			5 8		

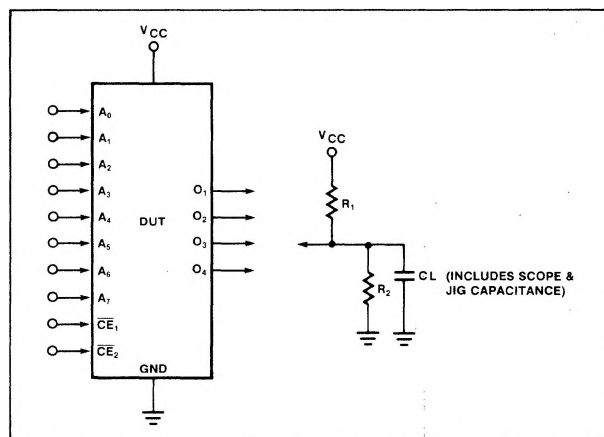
AC ELECTRICAL CHARACTERISTICS $R_1 = 270\Omega$, $R_2 = 600\Omega$, $C_L = 30\text{pF}$
 N82S226/229: $0^{\circ}\text{C} \leq T_A \leq +75^{\circ}\text{C}$, $4.75\text{V} \leq V_{CC} \leq 5.25\text{V}$
 S82S226/229: $-55^{\circ}\text{C} \leq T_A \leq +125^{\circ}\text{C}$, $4.5\text{V} \leq V_{CC} \leq 5.5\text{V}$

PARAMETER	TO	FROM	N82S226/229			S82S226/229			UNIT
			Min	Typ ²	Max	Min	Typ ²	Max	
T_{AA} T_{CE}	Access time Output Output	Address Chip enable		35 15	50 25		35 15	70 35	ns
T_{CD}	Disable time Output	Chip disable		15	25		15	35	ns

NOTES

- Positive current is defined as into the terminal referenced.
- Typical values are at $V_{CC} = 5.0\text{V}$, $T_A = +25^{\circ}\text{C}$.

TEST LOAD CIRCUIT



VOLTAGE WAVEFORM

